



Advanced Simulations

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What we know so far

- **DC Simulation**
 - Determine g_m , r_{ds} , ...
 - Find operation points, dynamic range, ...
- **Transient Simulation**
 - Functionality
 - Risetimes
 - Large Signal behaviour
- **AC Simulation**
 - Good to assess bandwidth / speed as function of parameters (results can be better extracted than in transient)
 - Faster simulation
 - Only for small subcircuits
- **Mixed Mode**
 - Digital blocks are described easier / sim runs faster



Further Simulation Tools

- Parameters, Simulation Settings
- Waveform Calculator

- AC Noise
- Transient Noise

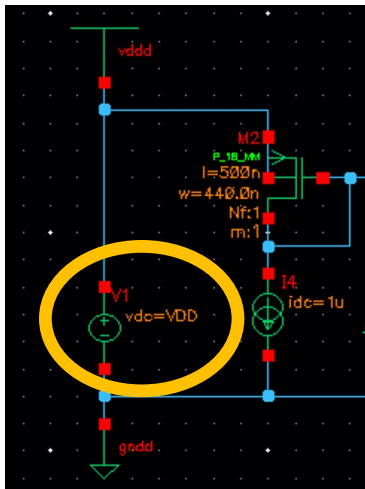
- Corner Simulation
- Monte Carlo Simulation

- Extracted Simulation

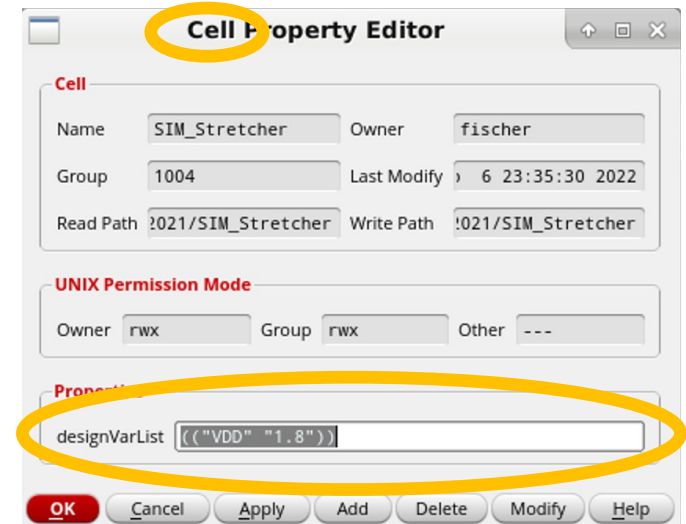
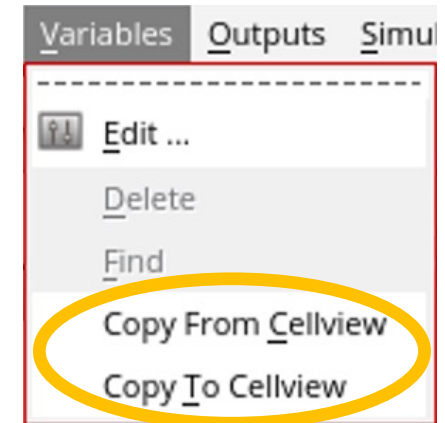
- Scripted Simulations with Ocean



Parameters



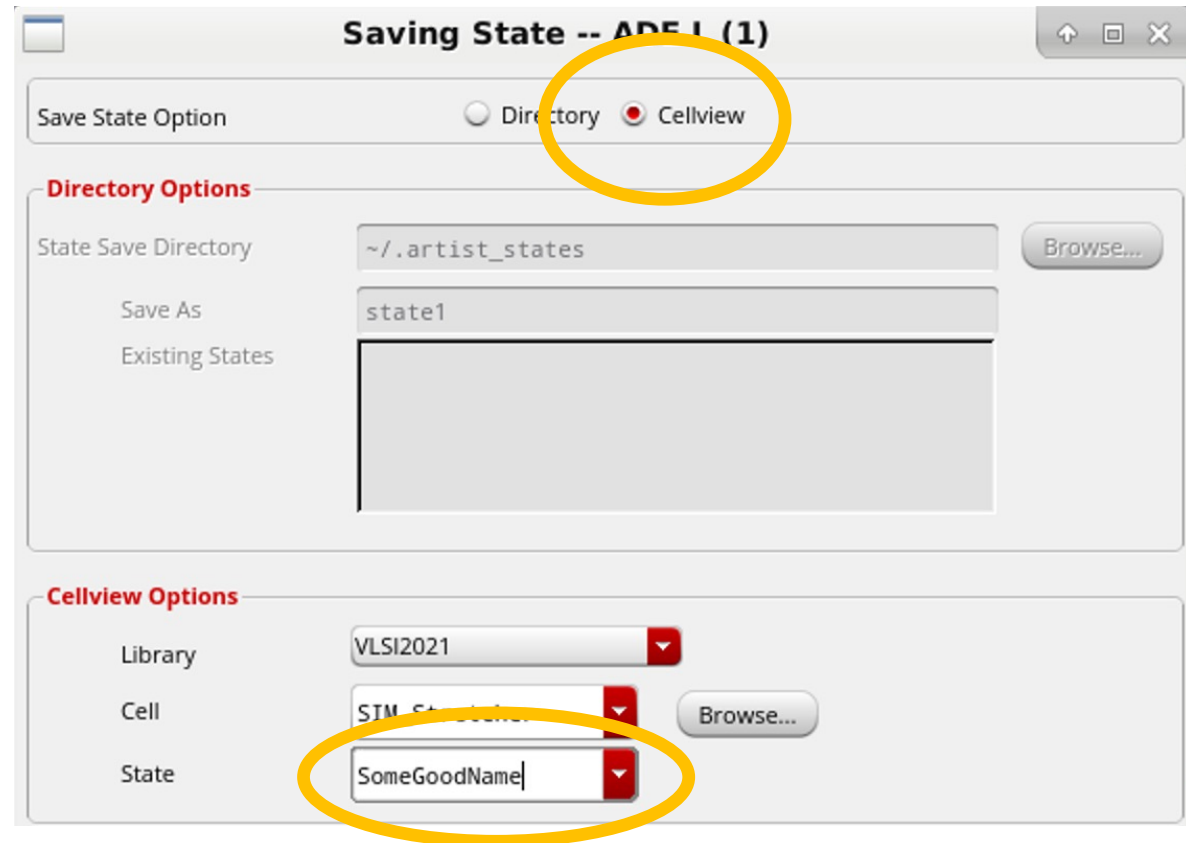
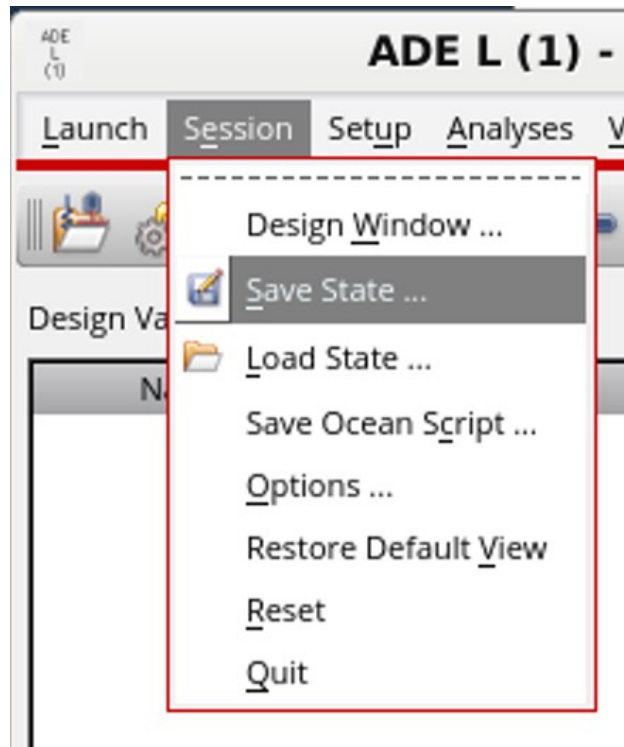
- If parameters are used in a schematic, they can be pulled to the simulator with Variables->Copy From Cellview
- Write them back to cell with Variables->Copy To Cellview
- If you do not use a parameter in the schematic any more, it is still stored and shows up when you get the parameters.
 - Delete it in the simulation window and write back to schematic
- Parameters are stored in the *cell*, not in a view (i.e. they are shared between views).
 - They can be seen in the library manager as properties of the cell (right click cell -> Properties)





Simulation Settings

- Can be saved with Session->Save State
- Best save to *Cellview* with a clear name

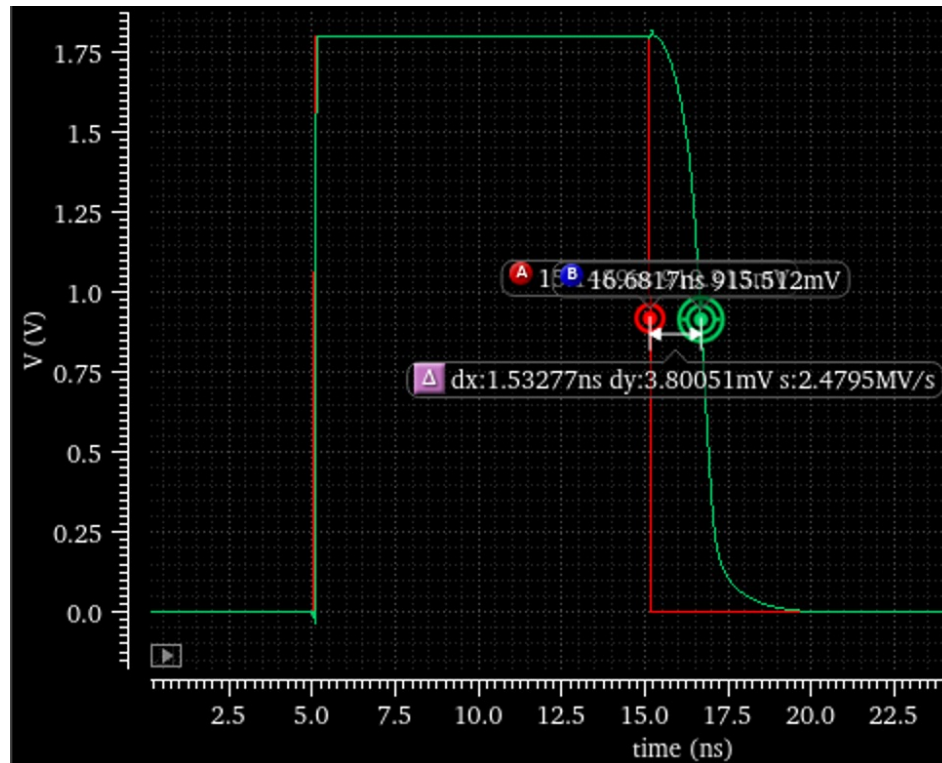




Waveform Viewer

■ Cursor

- “a” -> create cursor at position
- “b” -> differences are shown



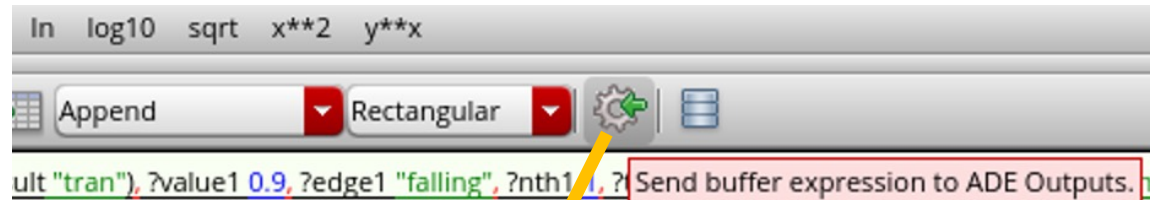
- “v” creates a cursor with a vertical line
- “m” adds an arbitrary number of markers



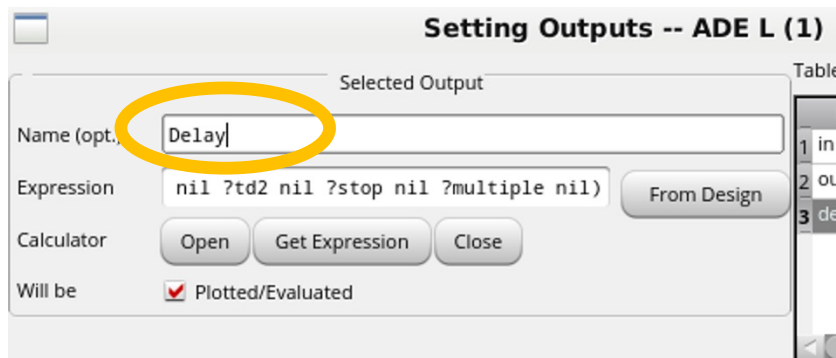
Waveform Calculator

- Can be used to analyse waveforms

- Click on wave
- open calculator



- Fix expression (e.g. derivative)
- Best send to ADE (button), so that it is conserved
- Assign a useful name in ADE



working

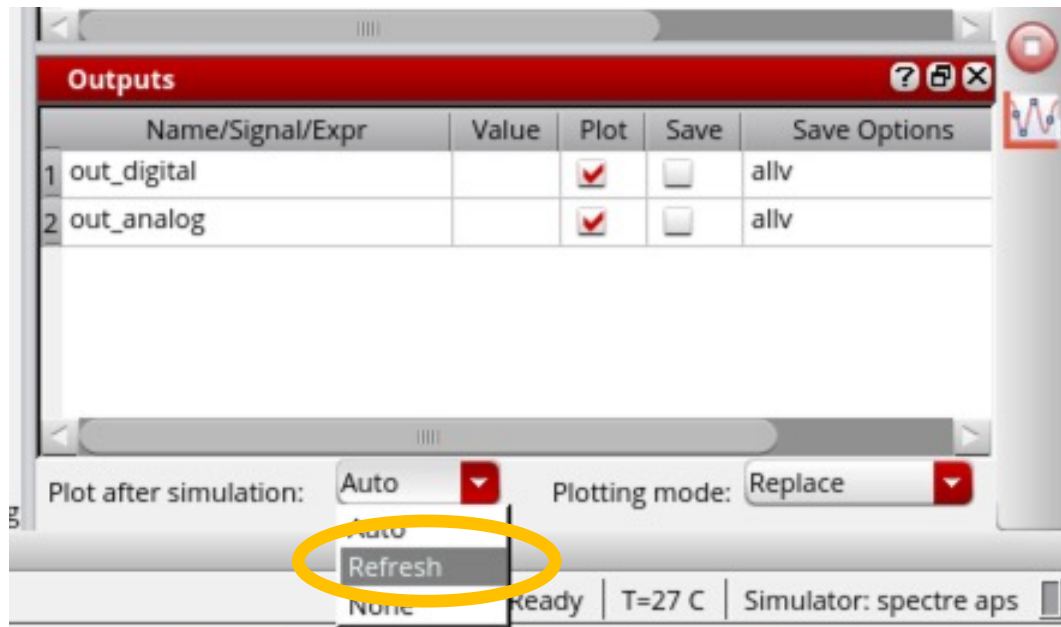
Name/Signal/Expr	Value	Plot	Save	Save Options
1 in		<input checked="" type="checkbox"/>	<input type="checkbox"/>	allv
2 out		<input checked="" type="checkbox"/>	<input type="checkbox"/>	allv
3 Delay	1.54n	<input checked="" type="checkbox"/>	<input type="checkbox"/>	

- NB: simulation variables can be accessed with
 - `pv("/name" "value" ?result "variables")` or `VAR("name")`
- Calculated expressions can be referred to just by the name



Keeping Display Order

- In the normal setting, all traces are re-drawn after a new simulation. A hand-made ordering (into sub-windows etc. gets lost
- This can be avoided by setting
- PlottingMode to ‚Refresh‘





FURTHER SIMULATION TYPES



AC Noise

- In this simulation type, the components generate noise voltages and currents (as function of frequency)
- The ‘output signal’ then also has noise, coming from various sources in the circuit
 - Total noise is calculated by integration over all frequencies.
- Details:
 - The (spectral) noise density depends on the components
 - It takes ‘text book’ values e.g. for resistors, these can be overridden
 - Components can be made ‘noiseless’ so that the effect of individual components can be studied
 - MOS devices need a noise model, which contains in particular the frequency dependent $1/f$ noise
 - Models are often unreliable....
 - Dependencies on component parameters (L) often wrong.



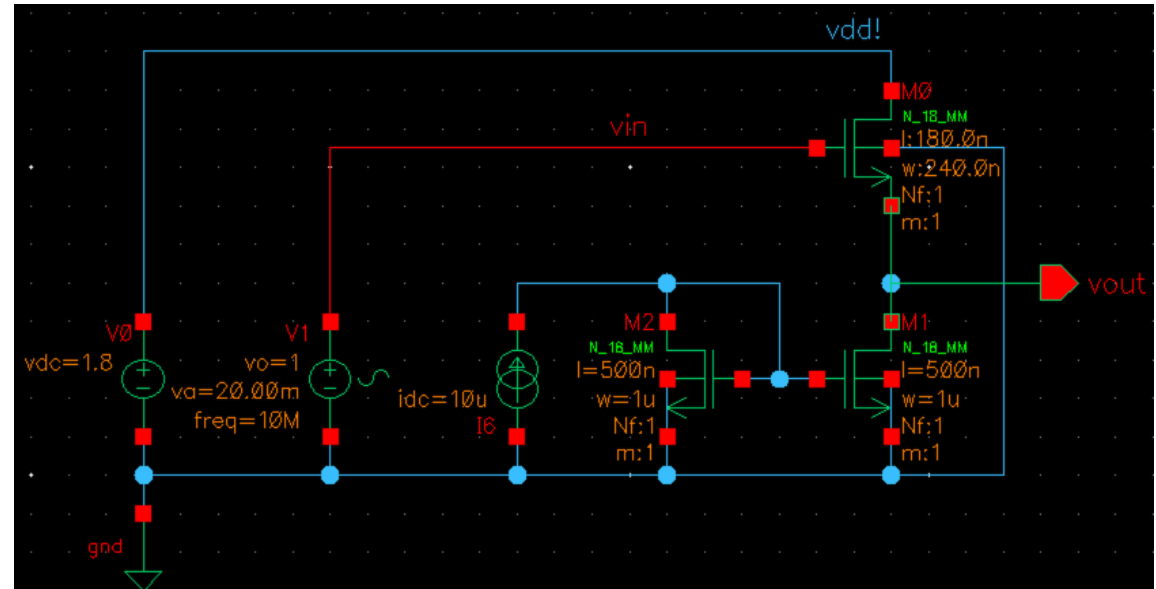
Transient Noise

- AC Noise simulation has drawbacks:
 - It is 'abstract' – needs clear understanding of what 'AC' is..
 - Needs careful analysis (integration)
 - It's **small signal** simulation. Large signal circuits (e.g. comparators) are hard to simulate
- Noise can also be generated in the time domain -> transient Noise analysis
 - 'Easy to use' (but noise sources must again be set up correctly!)
 - 'direct result'
 - Very slow, because time steps must be very small to take into account high frequency noise.
 - Simulators can do no 'tricks' to increase time steps because all signals change all the time (from their noise...)

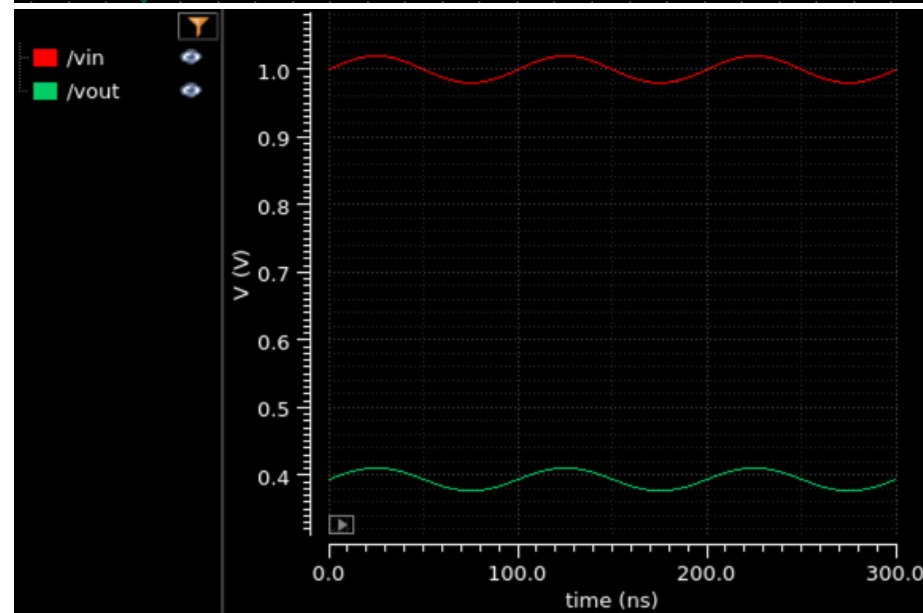


Transient Noise: Example

- Consider a source Follower:



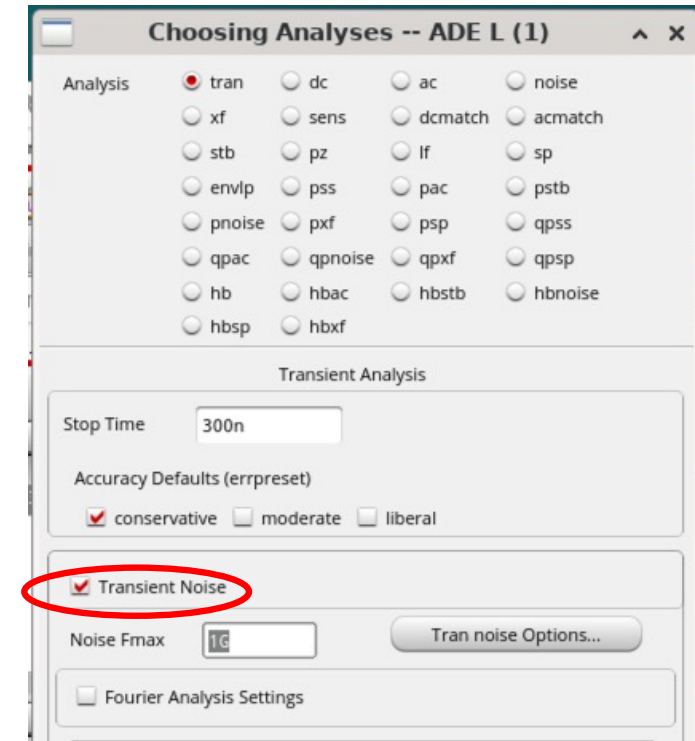
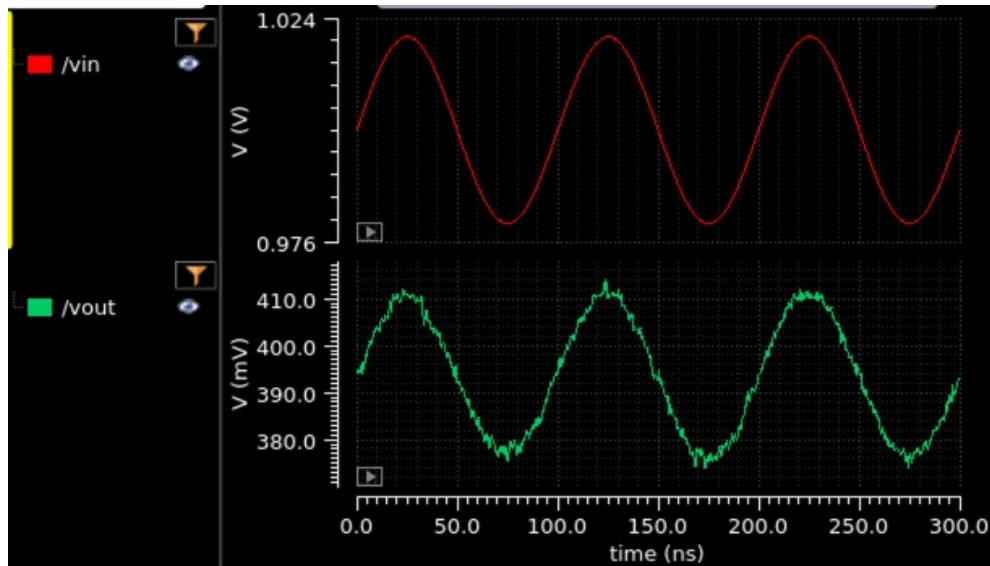
- Transient (noiseless):



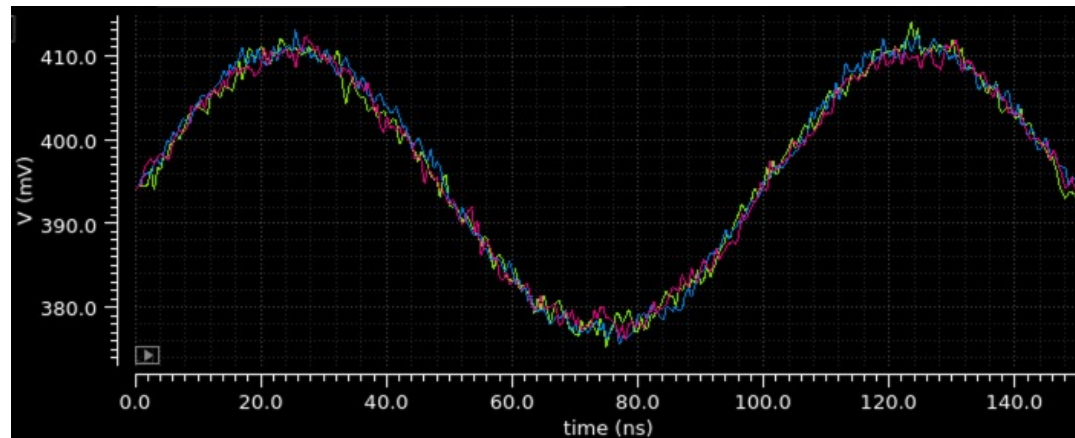


Transient Noise: Example

- Transient simulation with noise:
- Result:



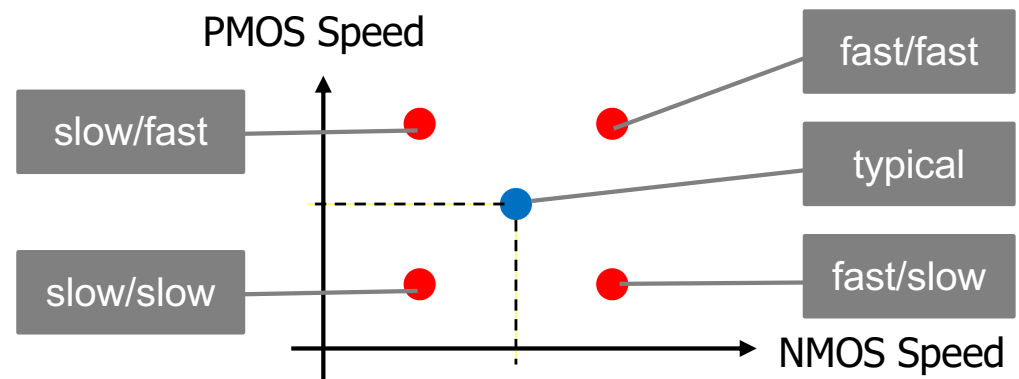
- Every Run is different ! :





Corner Simulation

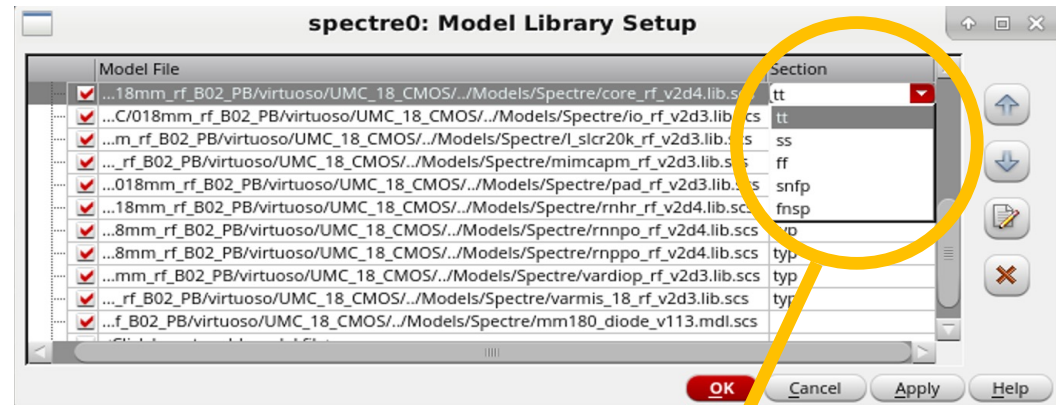
- The provided component models from the fab are for an *average* production, called a *'typical'* run.
- A production run can *systematically* deviate from 'typical' and devices behave differently. Such a run can still be 'in specs' because the vendor does not promise exact values for all parameters but ranges
 - e.g.: V_{Th} is typically 0.5 V, but can range from 0.4 ... 0.6 V
- Most vendors provide additional sets of model files for such 'corner' runs (i.e. runs which are 'just ok')
 - Most critical components are NMOS and PMOS
 - Models are often
 - tt – typical
 - ss – slow/slow
 - sf – slow/fast
 - ...





Corner Simulation

- You should simulate all 5 cases!
- ff gives ‘*highest speed*’, but *maximal power consumption*!
 - (fast: devices with lower threshold, higher K-factor, higher supply,..)
- ss gives *critical speed of design*
- sf and fs have large asymmetries between NMOS and PMOS and can be *dangerous*!
 - e.g.: Can a SRAM cell still be written if NMOS is weak and PMOS is strong?



- Technically
 - Sometimes, must change model files
 - Sometimes, ONE model file has several ‘*sections*’
- It can be impossible or tricky to ‘loop’ over all 5 models to see all results in one parametric plot....



Monte Carlo Simulation

- Different (identically sized) devices on a chip are not ***exactly*** the same in reality.
- Small variations between ‘identical’ devices may be a problem, e.g.
 - Input offset voltage of amplifiers
 - Nonlinearity in segmented DACs
- In a ‘Monte Carlo’ Simulation, the parameters of ***each device in the circuit*** are varied a bit (randomly)
- By running many simulations (with new variations), the sensitivity of the circuit can be quantified.
- This needs information about the ‘real’ variation of all parameters, for instance average value and standard dev.
 - Quality of these parameters sometimes not clear...

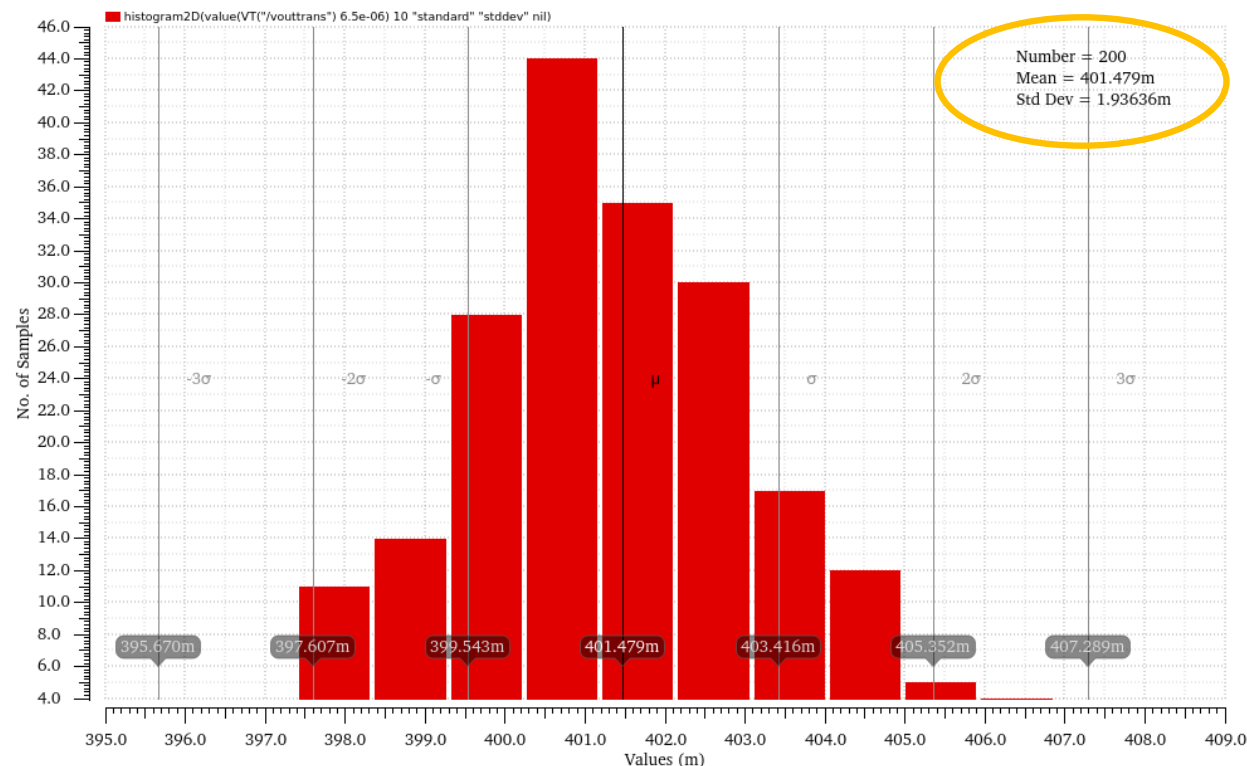


Monte Carlo Simulation

- Result of a Monte Carlo Run is a ‘probability’ distribution of a certain parameter, for instance
 - DC input level of an amplifier
 - Voltage output of a voltage reference
 - Threshold of a comparator

histogram2D(value(VT("/vouttrans") 6.5e-06) 10 "standard" "stddev" nil)

1





Parasitic (Extracted) Simulation

- The interconnections in schematics are idealised.
 - MOS caps and Source/Drain diode caps are taken into account for by models!
 - (Best immediately think at ‘other cells’ that will be connected to a signal later!..)
- In reality, traces have R and C
 - This will affect (slow down) the circuit and produce crosstalk
- ‘Parasitic’ Rs and Cs are only known when layout is done.
- They can be extracted with suited tools -> ‘extracted netlist’
- This netlist can be used in simulation instead of the ideal netlist to get ‘real’ behaviour.
- Advice: Try to anticipate long traces and put them as extra caps in the simulation schematic right away!



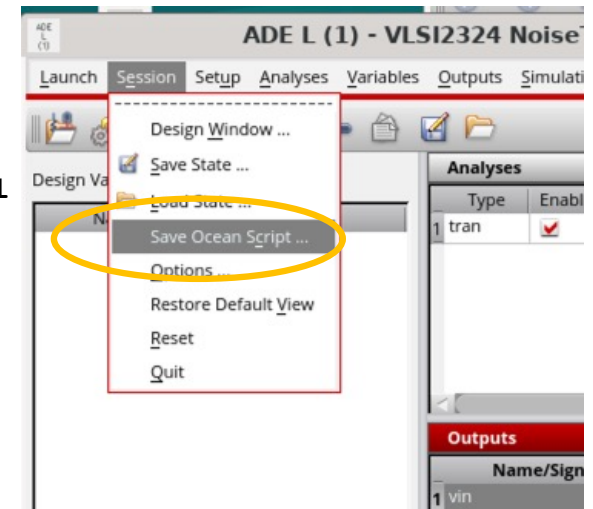
Scripted Simulations with Ocean - Cool & Easy!

- Repetitive simulations can be scripted using 'oceanscript'
- These are basically SKILL commands controlling spectre
- Start with an ADE simulation. Then export that simulation to an ocean script (.oce) from ADE->Session->Save Ocean...

```

simulator( 'spectre )
design("/tmp/ADE-Sim-
fischer/NoiseTran/spectre/schematic/netlist/netlist")
resultsDir("/tmp/ADE-Sim-fischer/NoiseTran/spectre/schematic" )
modelFile(
    ("somefile.scs" "tt") ; "tt" is the corner section typical/typical
    ; include here some more files
)
analysis('tran ?stop "300n" ?tranNoise "Transient Noise" ... more
parameters ... )
envOption('autoDisplay nil 'analysisOrder list("tran") )
saveOption( ?outputParamInfo t ) ; some options...
temp( 27 )

run()
selectResult( 'tran )
plot(getData("/vout") )
    
```



- Edit the skill file as you need.
- Run its from the CIW with (load "file.ocn")
- Note: netlist must exist!





Ocean Example

- Vary dc offset of source follower (p.11) input and measure output amplitude
- Minimalistic file, writing some data to 'Results.txt'

```

simulator( 'spectre )
design("/tmp/ADE-Sim-fischer/NoiseTran/spectre/schematic/netlist/netlist") ; This netlist must exist!
resultsDir("/tmp/ADE-Sim-fischer/NoiseTran/spectre/schematic") ; (create it by running ADE)
modelFile(
'("/opt/eda/UMC/018mm_rf_B02_PB/virtuoso/Models/Spectre/mm180_reg18_v124.lib.scs" "tt")
)
analysis('tran ?stop "300n" )
envOption('autoDisplay nil 'analysisOrder list("tran") )
temp( 27 )

; Self-made SKILL code starts here
p = outfile("Result.txt" "w") ; open a file for writing
(foreach os (list 0.1 0.2 0.5 0.5 0.6 0.8 1 1.2 1.6) ; pick some offset values (here from a list)
  desVar("VOFFSET" os) ; assign them to design variable
  run() ; run the simulation
  selectResult( 'tran ) ; get the result
  (fprintf p "Offset = %5.3f, Amplitude = %5.3f\n" ; write to file: offset
    (float os) peakToPeak(v("/vout" ?result "tran-tran")) ; and peakToPeak amplitude (from calculator)
  )
)
; end of (fprintf ...)
(close p)

```

-> File Result.txt:

Offset	Amplitude
0.100	0.000
0.200	0.000
0.500	0.015
0.500	0.015
0.600	0.022
0.800	0.032
1.000	0.034
1.200	0.034
1.600	0.034

NMOS Source Follower does not work for low input amplitudes

Gain < 1
(Input amplitude is 40 mV_{pp})